

Notice of References Cited	Application/Control No. 09/886,776	Applicant(s)/Patent Under Reexamination MENDIS ET AL.	
	Examiner John M. Villecco	Art Unit 2612	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,777,660	08-2004	Lee, Hae-Seung	348/308
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Pain et al.; "An Enhanced-Performance CMOS Imager with a Flushed-Reset Photodiode Pixel"; January 2003; IEEE Transactions on Electron Devices; Vol. 50, No. 1; pages 48-56
	V	Pain et al.; "Reset Noise Suppression in Two-Dimensional CMOS Photodiode Pixels through Column-based Feedback-Reset"; IEEE; 2002
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.